

Search Notes**Application/Control No.**

10/668,607

Examiner

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Applicant(s)/Patent under Reexamination

JOO ET AL.

Art Unit

2817

SEARCHED

Class	Subclass	Date	Examiner
330	133	11/18/2004	NKV
330	134	11/18/2004	NKV
330	252	12/20/2004	NKV
330	302	11/18/2004	NKV
330	310	11/18/2004	NKV
330	311	11/18/2004	NKV

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB)	4/15/2005	NKV

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
CLASSES	ABOVE	4/15/2005	NKV